规格书编号 ：

SPEC NO :

产品规格书
SPECIFICATION

CUSTOMER 客 户：

PRODUCT 产 品：SAW FILTER

MODEL NO 型 号：HDBF07015A64 SF6-4

PREPARED 编 制：汤康君 CHECKED 审 核：

APPROVED 批 准： D A T E 日 期：2010-11-11

客户确认 CUSTOMER RECEIVED:		
审核 CHECKED	批准 APPROVED	日期 DATE

无锡市好达电子有限公司
Shoulder Electronics Limited

更改历史记录
History Record

更改日期 Date	规格书编号 Spec. No.	产品型号 Part No.	客户产品型号 Customer No.	更改内容描述 Modify Content	备注 Remark

1. SCOPE

This specification shall cover the characteristics of SAW filter with HDBF07015A64 used for the page system.

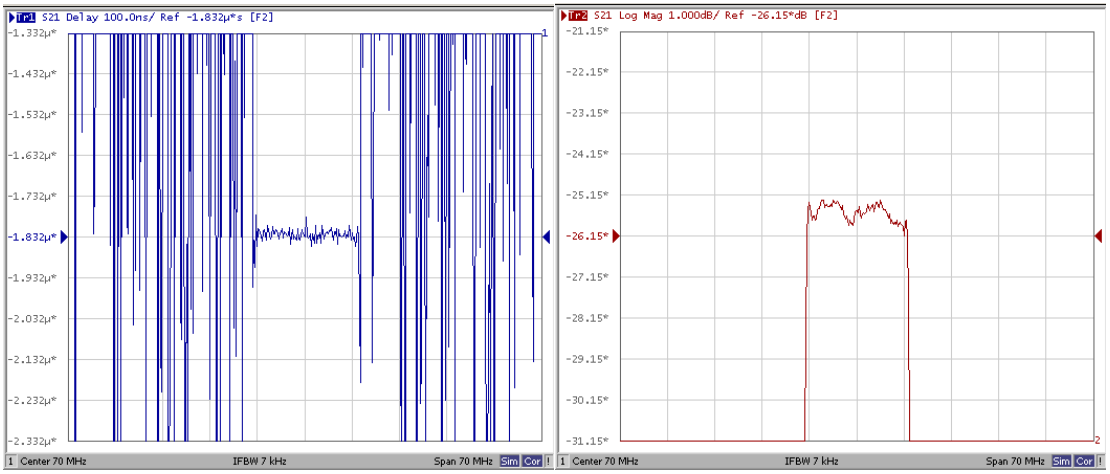
2. ELECTRICAL SPECIFICATION

Maximum Input Power	+10dBm
DC voltage	10V
Storage Temperature Range	-45℃ to +85℃
Operation Temperature Range	-40℃ to +85℃

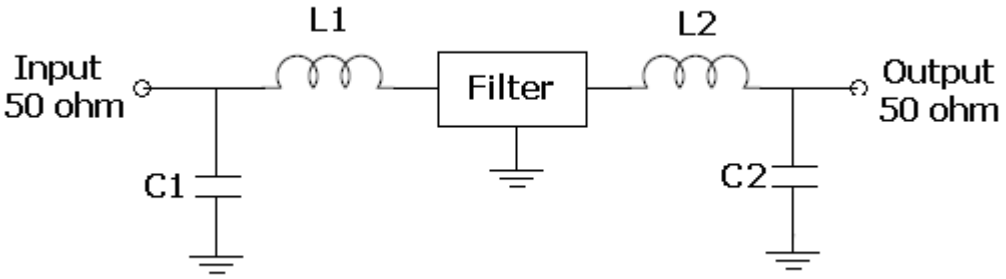
Electronic Characteristics

Parameter	Min.	Typical.	Max.	Unit
Center Frequency	69.8	70	70.2	MHz
Insertion loss		25	26	dB
Passband ripple(-1 dB)		0.9	1.5	dB
-1dB Bandwidth	14.2	14.8		MHz
-3dB Bandwidth	15	15.2		MHz
-40dB Bandwidth		16.3	16.4	MHz
Rejection: 16MHz—63MHz 77MHz—140MHz	 50 55	 55 60		dB
Absolute Delay		3.9	4.2	usec
Group Delay Variation		100	120	nsec
Temperature Coefficient	-87			ppm/°C
Package Size	SF6-4			

Typical Frequency Response

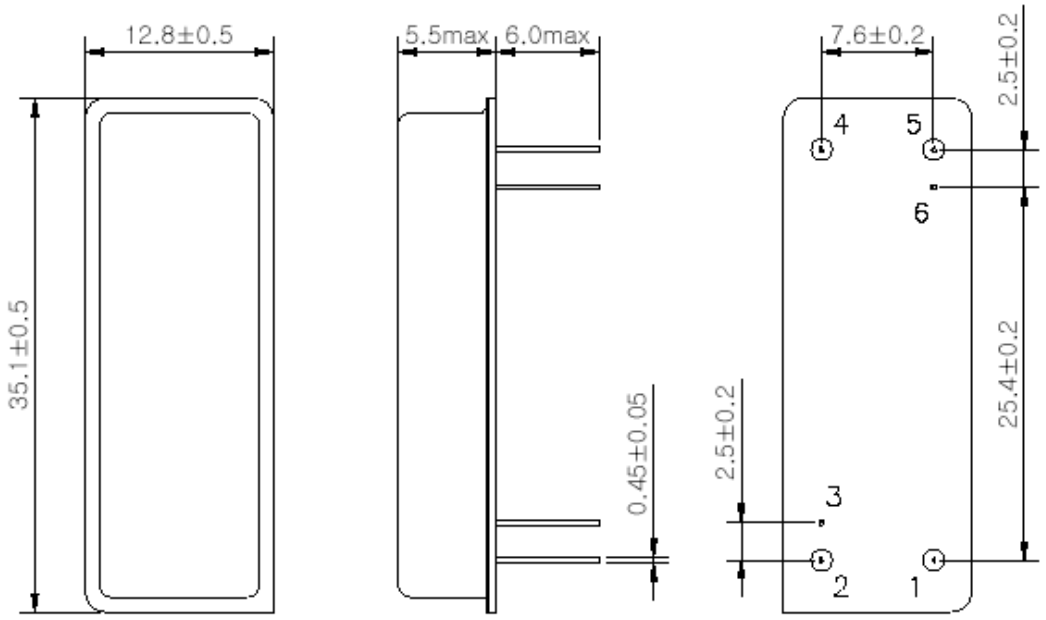


3. TEST CIRCUIT



Input : L1 = 120 nH , C1 = 0 pF
Output : L2 = 120 nH , C2 =9 pF
* Component values may change depending on board layout.

4.DIMENSION



Pin Configuration	
1	Input
5	Output
2, 4	Ground
Other	Case ground

5. ENVIRONMENTAL CHARACTERISTICS

5-1 High temperature exposure

Subject the device to +85℃ for 16 hours. Then release the filter into the room conditions for 24 hours prior to the measurement. It shall fulfill the specifications in 2.2.

5-2 Low temperature exposure

Subject the device to -40℃ for 16 hours. Then release the device into the room conditions for 24 hours prior to the measurement. It shall fulfill the specifications in 2.2.

5-3 Temperature cycling

Subject the device to a low temperature of -40℃for 30 minutes. Following by a high temperature of +85℃ for 30 Minutes. Then release the device into the room conditions for 24 hours prior to the measurement. It shall meet the specifications in 2.2.

5-4 Resistance to solder heat

Dip the device terminals no closer than 1.5mm into the solder bath at 260℃ ±10℃ for 10±1 sec. Then release the device into the room conditions for 4 hours. The device shall meet the specifications in 2.2.

5-5 Solderability

Subject the device terminals into the solder bath at 245℃ ±5℃ for 5s, More than 95% area of the terminals must be covered with new solder. It shall meet the specifications in 2.2.

5-6 Mechanical shock

Drop the device randomly onto the concrete floor from the height of 1m 3 times. the device shall fulfill the specifications in 2.2.

5-7 Vibration

Subject the device to the vibration for 1 hour each in x,y and z axes with the amplitude of 1.5 mm at 10 to 55 Hz. The device shall fulfill the specifications in 2.2.

6. REMARK

6.1 Static voltage

Static voltage between signal load & ground may cause deterioration &destruction of the component. Please avoid static voltage.

6.2 Ultrasonic cleaning

Ultrasonic vibration may cause deterioration & destruction of the component. Please avoid ultrasonic cleaning

6.3 Soldering

Only leads of component may be soldered. Please avoid soldering another part of component.